

SSC8L38PN4

N-Channel Enhancement Mode MOSFET

> Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	ID
30V	±20V	2.3mΩ@10V	004
		3.5mΩ@4.5V	98A

> Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

100% UIS + ΔVDS + Rg Tested!

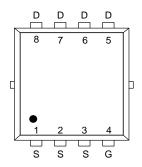
Applications

- Motor Drive Control
- Portable Devices
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

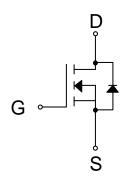
Ordering Information

Device	Package	Shipping
SSC8L38PN4	PDFN3.3X3.3-8L	5000/Reel

Pin Configuration



PDFN3.3X3.3-8L (Top View)



Pin Configuration



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V _{DSS}	Drain-to-Source Voltage		30	V
V _{GSS}	Gate-to-Source Volta	Gate-to-Source Voltage		V
	Continuous Drain Current d	T _C =25℃	98	^
l _D		T _C =100℃	54	Α
	Outline Paris Commits	T _A =25℃	27	Δ.
ldsм	Continuous Drain Current ^a	T _A =70°C	19	A
Ірм	Pulsed Drain Curren	Pulsed Drain Current ^b		
5	Power Dissipation °	Tc=25℃	39	14/
P _D		Tc=100℃	15	W
<u> </u>	Power Dissipation ^a	T _A =25℃	3.0	14/
P _{DSM}		T _A =70℃	1.9	W
I _{AS}	Avalanche Current b L=0.5mH \$	22	Α	
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		121	mJ
TJ	Operation junction temperature		-55~150	°C
Тѕтс	Storage temperature ra	-55~150	$^{\circ}$	

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Max.	Unit
R _{θJA}	Junction-to-Ambient Thermal Resistance a	42	60	°C/W
$R_{ heta JC}$	Junction-to-Case Thermal Resistance	3.2	4.0	CIVV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

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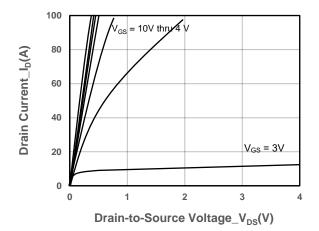


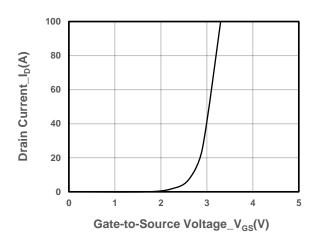
\succ Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250µA	30			V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250$ uA	1.0	1.7	2.5	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 20A		2.3	3.3	mΩ
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5V, I _D = 10A		3.5	5.3	mΩ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V			1	μΑ
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Transconductance	G _{FS}	V _{DS} = 5V, I _D = 10A		27		S
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 20A		0.7	1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		2.5		Ω
Input Capacitance	Ciss	V 45V V 0V		1448		
Output Capacitance	Coss	$V_{DS} = 15V, V_{GS} = 0V,$		937		pF
Reverse Transfer Capacitance	Crss	f = 1MHz		48		
Total Gate Charge	Q _G	10/// 15//		46		
Gate to Source Charge	Q _G s	$V_{GS} = 10V, V_{DS} = 15V,$		9.1		nC
Gate to Drain Charge	Q _{GD}	I _D = 20A		5.2		
Turn-on Delay Time	T _{D(ON)}			5.1		
Rise Time	Tr	V _{GS} = 10V, V _{DS} = 20V,		5.6]
Turn-off Delay Time	T _{D(OFF)}	$R_L = 1\Omega$, $R_G = 3\Omega$		25		ns
Fall Time	T _f			20		
Diode Recovery Time	Trr	I _F =20A, di/dt=100A/us		34		ns
Diode Recovery Charge	Q _{rr}	I _F =20A, di/dt=100A/us		18		nC



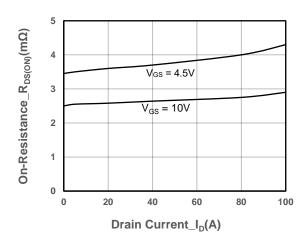
➤ Typical Performance Characteristics (T_A=25°C unless otherwise noted)

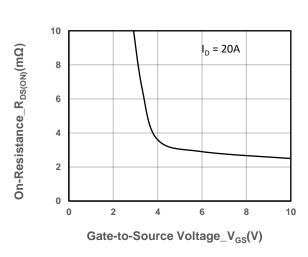




Output Characteristics

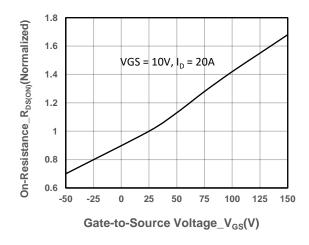
Transfer Characteristics

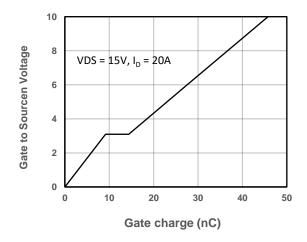




On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage



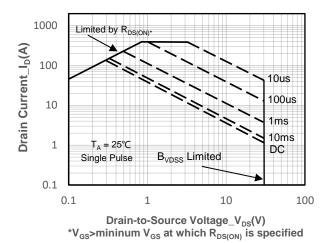


On-Resistance vs. Junction Temperature

Gate-Source Voltage vs. Gate charge



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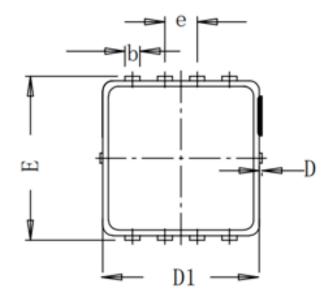
Safe Operating Area vs. Junction-to-Ambient

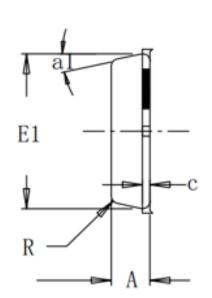
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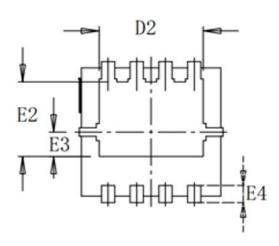
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Package Information







Cymbal	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
Α	0.75	0.78	0.81	
b	0.297	0.3	0.35	
С	-	0.152	-	
D	0	0.05	0.1	
D1	3.12	3.15	3.18	
D2	-	2.35	-	
E	3.2	3.3	3.4	
E1	3.09	3.12	3.15	
E2	-	1.75	1	
E3	-	0.575	•	
E4	-	0.4	•	
R	-	0.15	-	
е	0.65BSC			
a1°	-	12°	-	



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